

AOWF11N60 600V,11A N-Channel MOSFET

General Description

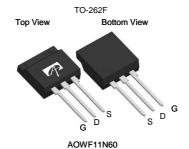
The AOWF11N60 has been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications.By providing low $R_{\rm DS(on)},\,C_{\rm iss}$ and $C_{\rm rss}$ along with guaranteed avalanche capability this device can be adopted quickly into new and existing offline power supply designs.

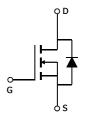
Product Summary

 $\begin{array}{ll} V_{DS} & 700V@150^{\circ}C \\ I_{D} \ (at \ V_{GS} = 10V) & 11A \\ R_{DS(ON)} \ (at \ V_{GS} = 10V) & < 0.65\Omega \end{array}$

100% UIS Tested 100% R_g Tested







Absolute Maximum Ratings	T _A =25℃ unless otherwise noted
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Parameter		Symbol	AOWF11N60	Units
Drain-Source Voltage		V _{DS}	600	V
Gate-Source Voltage		V _{GS}	±30	V
Continuous Drain	T _C =25℃		11*	
Current	T _C =100℃	I _D	8*	A
Pulsed Drain Current ^C		I _{DM}	39	
Avalanche Current ^C		I _{AR}	4.8	А
Repetitive avalanche energy ^C		E _{AR}	345	mJ
Single plused avalanche energy ^G		E _{AS}	690	mJ
Peak diode recovery	dv/dt	dv/dt	5	V/ns
	T _C =25℃	P _D	27.8	W
Power Dissipation ^B	Derate above 25°C	' D	0.22	W/°C
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C
Maximum lead temperature for soldering				
purpose, 1/8" from case for 5 seconds		T _L	300	C

Thermal Characteristics					
Parameter	Symbol	AOWF11N60	Units		
Maximum Junction-to-Ambient A,D	$R_{\theta JA}$	65	℃/W		
Maximum Junction-to-Case	$R_{\theta JC}$	4.5	℃/W		

^{*} Drain current limited by maximum junction temperature.



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS} Drain-Source Breakdown Voltage	Dunin Course Dunaledour Valtage	I _D =250μA, V _{GS} =0V, T _J =25℃	600						
	Dialii-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V, T _J =150℃		700		V			
BV _{DSS}	Tzero Gare Voltage Drain Current	ID=250µA, VGS=0V		0.67		V/°C			
/∆TJ		15-230μΛ, ₹30-0₹		0.07		V/ C			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =600V, V _{GS} =0V			1	μА			
.033		V _{DS} =480V, T _J =125℃			10				
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±30V			±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =5V I _D =250μA	3.3	3.9	4.5	V			
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =5.5A		0.56	0.65	Ω			
g _{FS}	Forward Transconductance	V_{DS} =40V, I_{D} =5.5A		12		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.73	1	V			
I_S	Maximum Body-Diode Continuous Current				11	Α			
I _{SM}	Maximum Body-Diode Pulsed Current				39	Α			
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance		1320	1656	1990	pF			
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =25V, f=1MHz	100	146	195	pF			
C _{rss}	Reverse Transfer Capacitance		6.5	11.2	16	pF			
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	1.7	3.5	5.3	Ω			
SWITCHI	NG PARAMETERS								
Q_g	Total Gate Charge		24	30.6	37	nC			
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =480V, I _D =11A		9.6		nC			
Q_{gd}	Gate Drain Charge			9.6		nC			
t _{D(on)}	Turn-On DelayTime			39		ns			
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =300V, I_{D} =11A,		58		ns			
t _{D(off)}	Turn-Off DelayTime	$R_G=25\Omega$		92		ns			
t _f	Turn-Off Fall Time	<u> </u>		42		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =11A,dI/dt=100A/μs,V _{DS} =100V	400	500	600	ns			
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =11A,dI/dt=100A/μs,V _{DS} =100V	4.7	5.9	7.1	μС			

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A. The value of R_{0JA} is measured with the device in a still air environment with T_A=25° C.

B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation that for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C, Ratings are based on low frequency and duty cycles to keep initial

T_J =25° C.

D. The R _{BJA} is the sum of the thermal impedence from junction to case R _{BJC} and case to ambient.

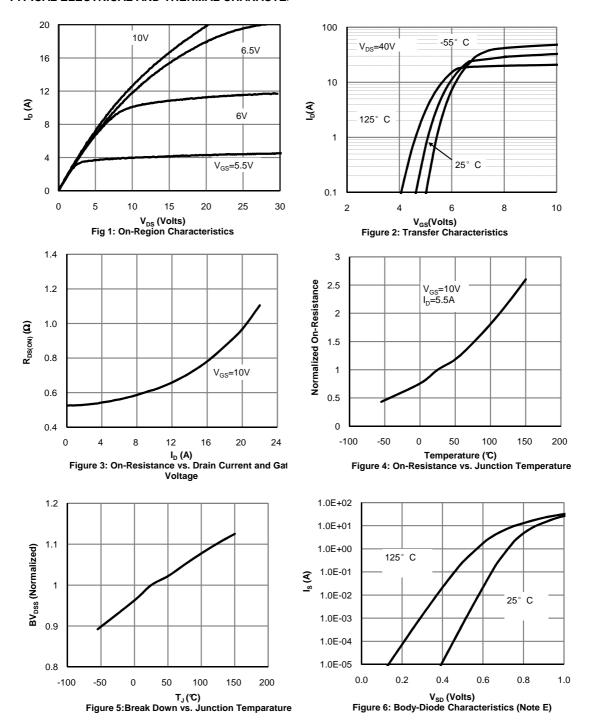
E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. L=60mH, I_{AS}=4.8A, V_{DD}=150V, R_G=25Ω, Starting T_J=25° C



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



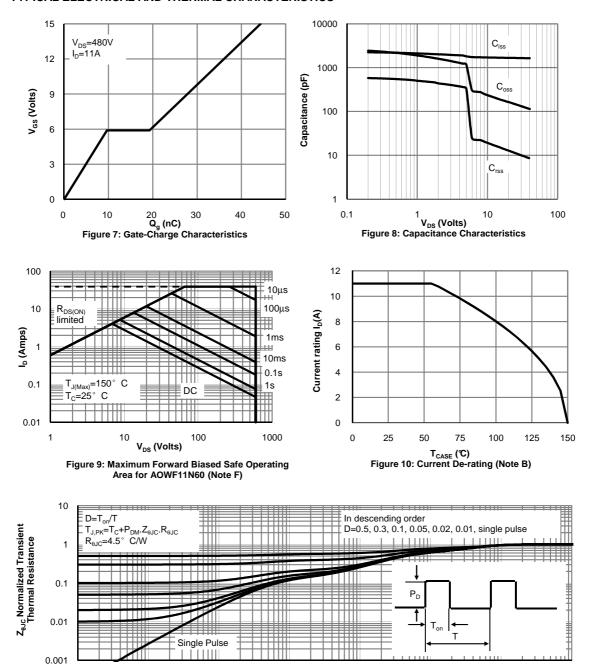


1E-05

0.0001

0.001

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance for AOWF11N60 (Note F)

0.01

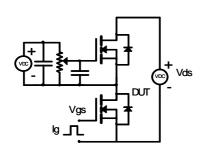
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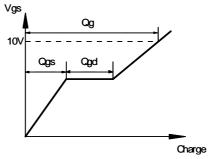
10

100

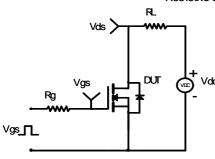


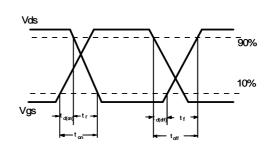
Gate Charge Test Circuit & Waveform



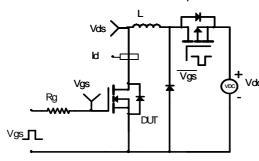


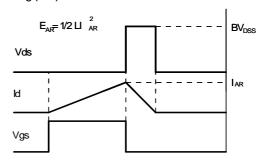
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

